

FUJI POWER MOSFET

Super J-MOS series

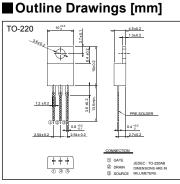
N-Channel enhancement mode power MOSFET

Features	
Low on-state resistance	

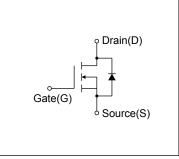
Low switching loss easy to use (more controllabe switching dV/dt by R_g)

Applications

UPS Server Telecom Power conditioner system Power supply







Absolute Maximum Ratings at Tc=25°C (unless otherwise specified)

Description	Symbol	Characteristics	Unit	Remarks
Drain Source Veltage	VDS	600	V	
Drain-Source Voltage	V _{DSX}	600	V	V _{gs} =-30V
Continuous Drain Current		±10	А	Tc=25°C Note*1
Continuous Drain Current	ID	±6.3	А	Tc=100°C Note*1
Pulsed Drain Current	IDP	±30	А	
Gate-Source Voltage	V _{GS}	±30	V	
Repetitive and Non-Repetitive Maximum Avalanche Current	lar	2.9	А	Note *2
Non-Repetitive Maximum Avalanche Energy	Eas	320	mJ	Note *3
Maximum Drain-Source dV/dt	dV₀s/dt	50	kV/µs	V _{DS} ≤ 600V
Peak Diode Recovery dV/dt	dV/dt	15	kV/µs	Note *4
Peak Diode Recovery -di/dt	-di/dt	100	A/µs	Note *5
Maximum Dawar Dissinction	D	2.02	W	T₄=25°C
Maximum Power Dissipation	P₀	90	vv	T₀=25°C
On anothing and Otanana Tamananatuma nanana	Tch	150	°C	
Operating and Storage Temperature range	T _{stg}	-55 to +150	°C	

Note *1 : Limited by maximum channel temperature. Note *2 : Tch≤150°C, See Fig.1 and Fig.2 Note *3 : Starting Tch=25°C, IAs=1.8A, L=181mH, VpD=60V, Rg=50Ω, See Fig.1 and Fig.2

EAs limited by maximum channel temperature and avalanche current. Note *4 : Ir≤-ID, -di/dt=100A/µs, VbD≤400V, Vpeak≤BVbss, Tch≤150°C.

Note *5 : IF≤-ID, dV/dt=15kV/µs, VDD≤400V, Vpeak≤BVDss, Tch≤150°C.

Electrical Characteristics at T_c=25°C (unless otherwise specified) Static Ratings

Description	Symbol	Conditions		min.	typ.	max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	I _D =250μA V _{GS} =0V		600	-	-	V
Gate Threshold Voltage	V _{GS(th)}	I₀=250µA V₀s=V₀s		2.5	3.0	3.5	V
Zero Gate Voltage Drain Current	loss	V _{DS} =600V V _{GS} =0V	T _{ch} =25°C	-	-	25	μA
		V _{DS} =480V V _{GS} =0V	T _{ch} =125°C	-	-	250	
Gate-Source Leakage Current	IGSS	V _{GS} = ± 30V V _{DS} =0V		-	10	100	nA
Drain-Source On-State Resistance	R _{DS(on)}	ID=5A VGS=10V		-	0.324	0.38	Ω
Gate resistance	RG	f=1MHz, open drain		-	3.2	-	Ω

Dynamic Ratings

Description	Symbol	Conditions	min.	typ.	max.	Unit
Forward Transconductance	g _{fs}	I _D =5A V _{DS} =25V	4.5	9.5	-	s
Input Capacitance	Ciss	V _{DS} =10V	-	760	-	
Output Capacitance	Coss	V _{GS} =0V	-	1630	-	
Reverse Transfer Capacitance	Crss	f=1MHz	-	145	-	
Effective output capacitance, energy related (Note *6)	C _{o(er)}	V _{GS} =0V V _{DS} =0480V	-	55	-	pF
Effective output capacitance, time related (Note *7)	C _{o(tr)}	V _{GS} =0V V _{DS} =0480V ID=constant	-	165	-	
Turne On Times	t _{d(on)}		-	11	-	ns
Turn-On Time	tr	V _{DD} =400V, V _{GS} =10V/0V	-	33	-	
Turn Off Time	td(off)		-	83	-	
Turn-Off Time	tr		-	17	-	
Total Gate Charge	QG	V _{DD} =480V, I _D =10A V _{GS} =10V See Fig.5	-	28	-	nC
Gate-Source Charge	Q _{GS}		-	8.5	-	
Gate-Drain Charge	Q _{GD}		-	7.5	-	
Drain-Source crossover Charge	Qsw		-	5.5	-	

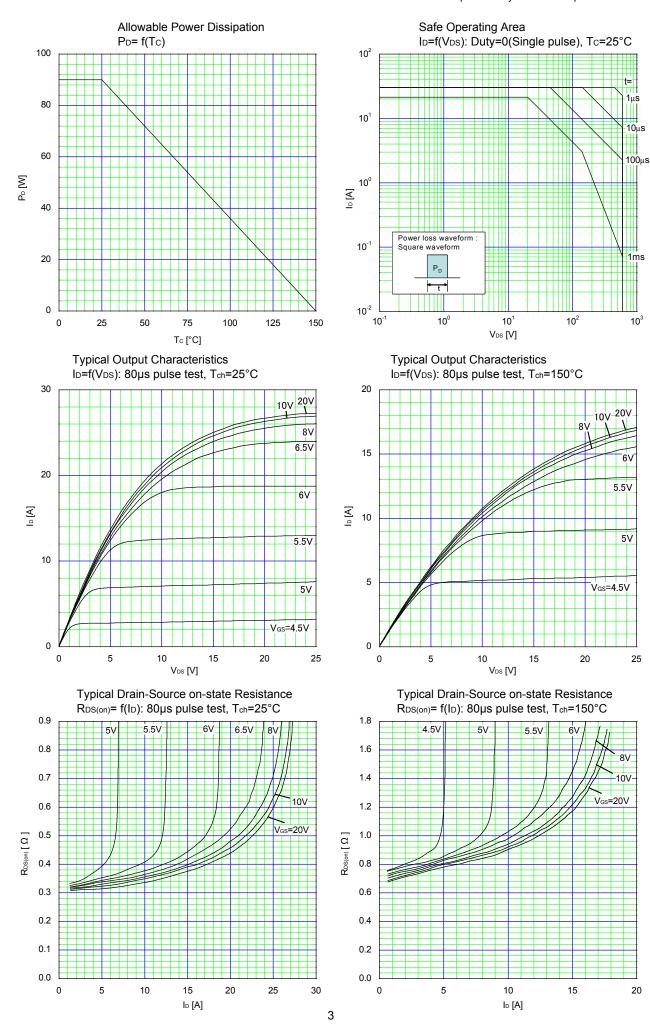
Note *6 : $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{Ds} is rising from 0 to 80% BV_{Dss}. Note *7 : $C_{o(tr)}$ is a fixed capacitance that gives the same charging times as C_{oss} while V_{Ds} is rising from 0 to 80% BV_{Dss}.

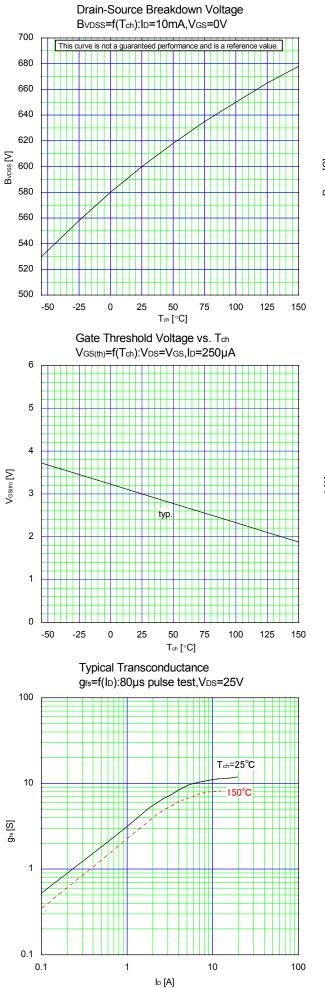
Reverse Diode

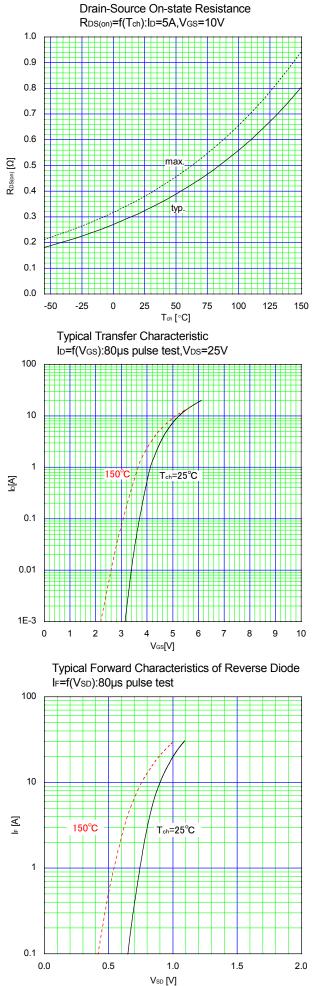
Description	Symbol	Conditions	min.	typ.	max.	Unit
Avalanche Capability	lav	L=43.3mH, T _{ch} =25°C See Fig.1 and Fig.2	2.9	-	-	А
Diode Forward On-Voltage	Vsd	I⊧=10A, V₀s=0V T₀h=25°C	-	0.9	1.35	V
Reverse Recovery Time	trr	I⊧=10A, V₀₀=400V -di/dt=100A/µs		310	-	ns
Reverse Recovery Charge	Qrr	$V_{GS(Q1)}$ =short, $V_{GS(Q2)}$ =10V/0V R _G =330Q	-	3.7	-	μC
Peak Reverse Recovery Current	Irp	Tc₀=25°C See Fig.6 and Fig.7	-	21	-	А

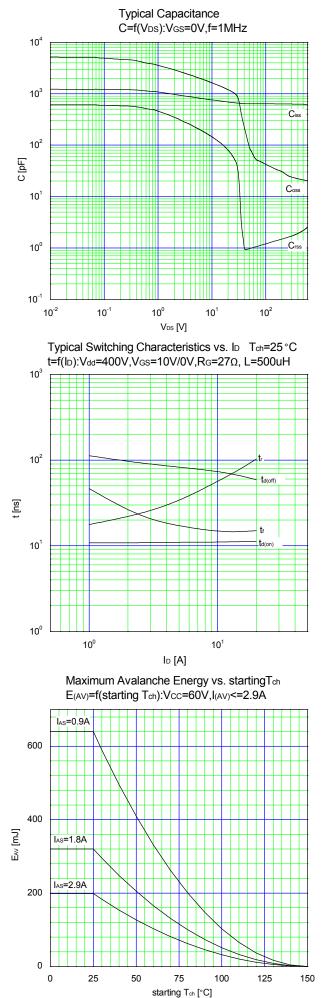
Thermal Resistance

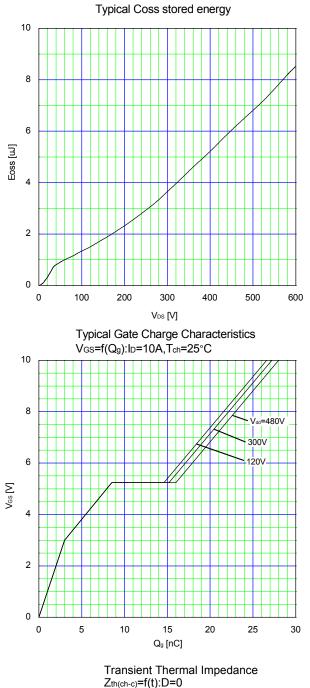
Parameter	Symbol	min.	typ.	max.	Unit
Channel to Case	Rth(ch-c)	-	-	1.39	°C/W
Channel to Ambient	Rth(ch-a)	-	-	62	°C/W

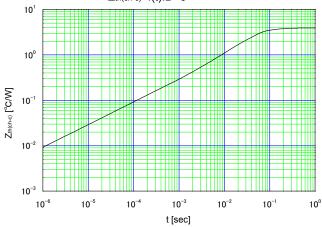












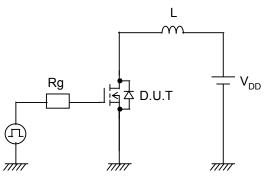


Fig.1 Avalanche Test circuit

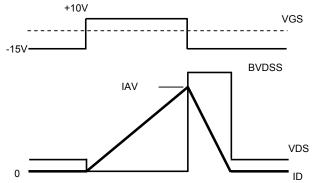
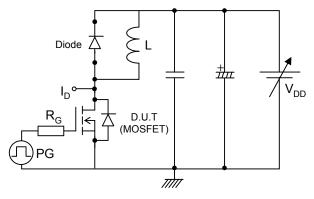


Fig.2 Operating waveforms of Avalanche Test





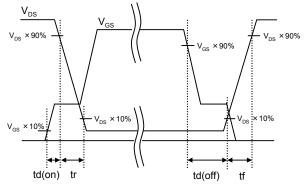


Fig.4 Operating waveform of Switching Test

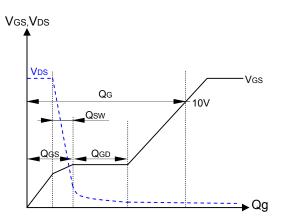


Fig.5 Operating waveform of Gate charge Test

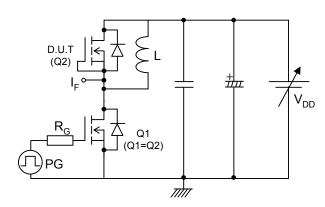


Fig.6 Reverse recovery Test circuit

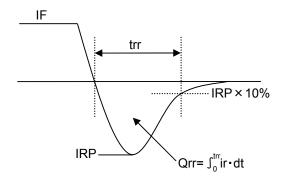
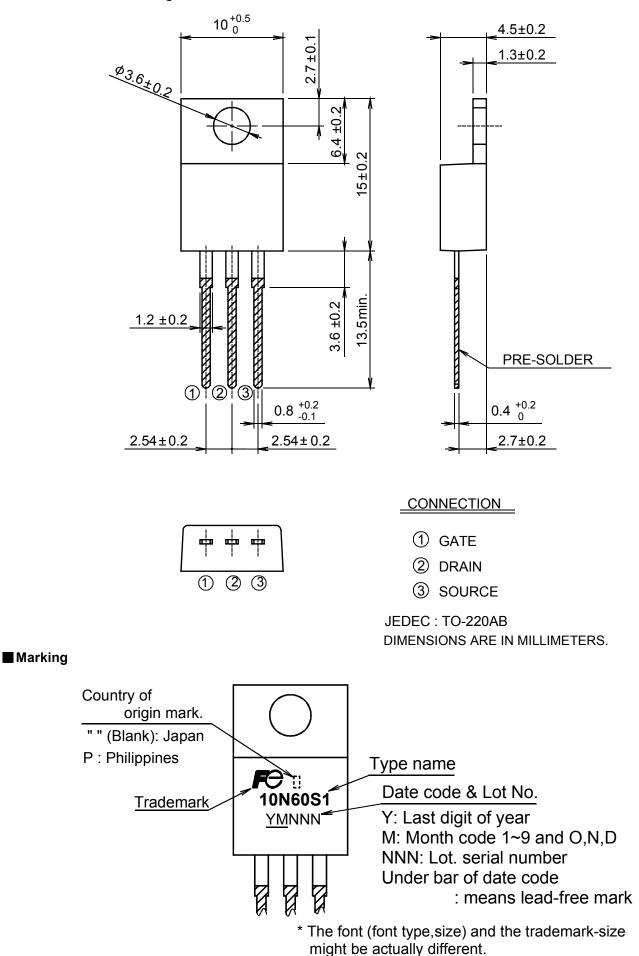


Fig.7 Operating waveform of Reverse recovery Test

Outview: TO-220 Package



set forth herein.

http://www.fujielectric.com/products/semiconductor/

WARNING

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